The Canadian Light Source

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CLS Director of Research
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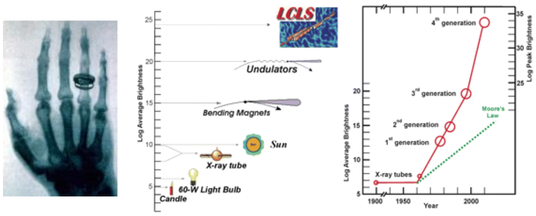
Surface Canada May 2013

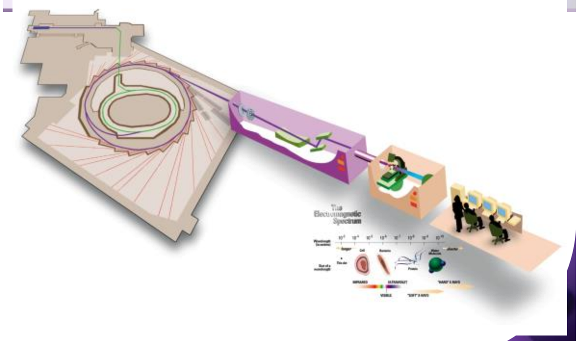
A Brief History of Synchrotron Radiation Sources

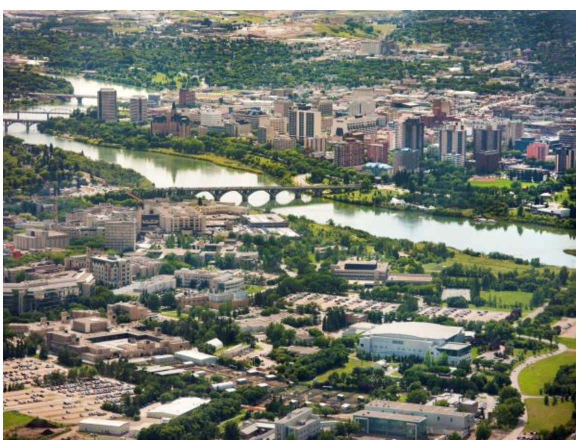
X-ray Brightness



Parise and Brown (2006)

How a synchrotron works





CLS Timeline

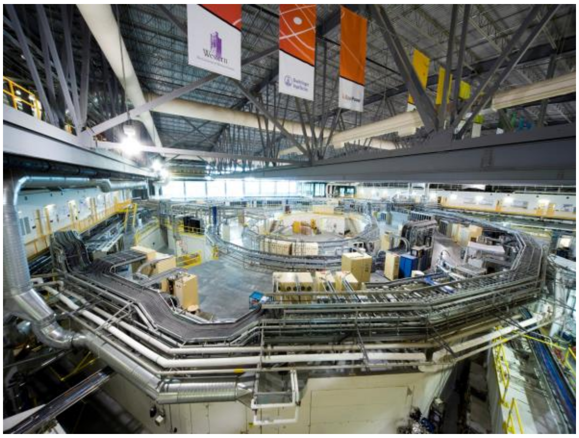
- **September 27, 1999** – Groundbreaking ceremony
- **February 26, 2001** – Building dedication ceremony
- **September 18, 2002** – Booster ring commissioning complete
- **December 9, 2003** – First synchrotron light detected
- **October 22, 2004** – Official opening
- **May 27, 2005** – First CLS user
- **June 30, 2005** – Official completion of the CFI project

Capital Investment to Date

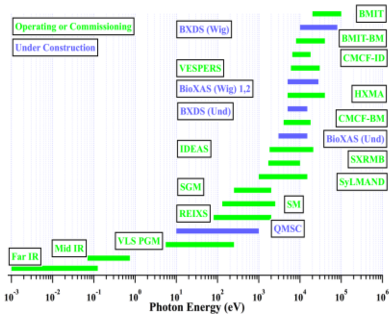
- Original Construction (7 beamlines) $141M
- Phase II (7 beamlines) 52M
- Phase III (7 beamlines & upgrade) 68M
- Isotopes Project 12M

CLS Features

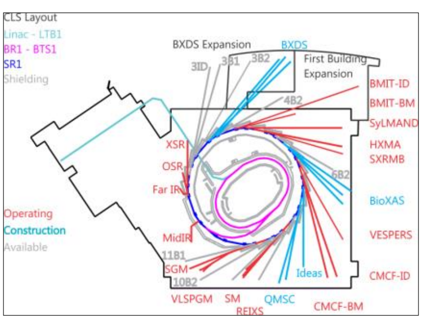
- Canada's national synchrotron facility
- One of the world's first ~3 GeV synchrotrons
  - Superconducting RF cavity
  - Canted insertion devices
  - Hard X-rays from superconducting wigglers
- Full spectrum of photon energies for spectroscopy (THz to hard X-rays)
- Other highlights: STXM, medical imaging, soft X-ray REIXS, soil science and mining applications



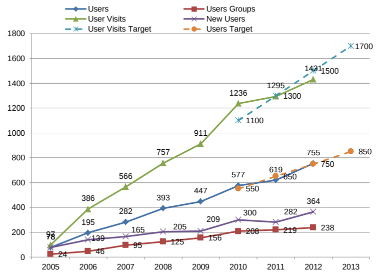
Energy Range



CLS Layout



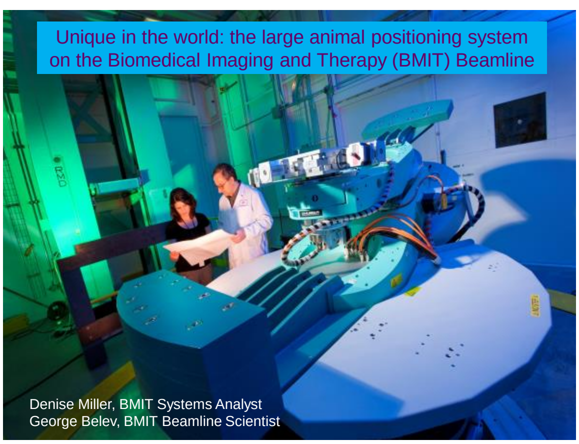
Users and User Visits



Prepared by Lavina Carter

The nature of our user base

Geographic distribution of shifts	2008	2009	2010
Canada – SK	560 (46%)	590 (35%)	716 (30%)
Canada – other provinces	554 (45%)	828 (49%)	1233 (52%)
International	114 (9%)	275 (16%)	406 (17%)



Call for Proposals

A call for proposals is issued twice per year for experimental beam time

Call Open	Proposal Deadline	Review Date (Safety, Technical, Peer Review)	Peer Review Meeting (week of)	Results Announced (week of)	Scheduling Period Begins	Scheduling Period Ends	Cycle
Jan.30/13	Feb.27/13	Apr. 8/13	Apr.29/13	May 13/13	July 1/13	Dec. 31/13	18
Aug.1/12	Sept.5/12	Oct.15/12	Nov. 5/12	Nov.19/12	Jan. 1/13	June 30/13	17

Submit a Proposal:
Step 1: Contact the appropriate CLSI beamline scientist to discuss your research.
Step 2: Logon to https://user.lightsource.ca.
If you have not previously registered you will be required to register and you will receive a username prior to submitting a proposal.

Peer Review

Evaluation Criteria
Each proposal is reviewed and scored by at least three external reviewers and at least one member of the Peer Review Committee. Reviewers are asked to provide an integer score in each of the three Evaluation Criteria, as described below

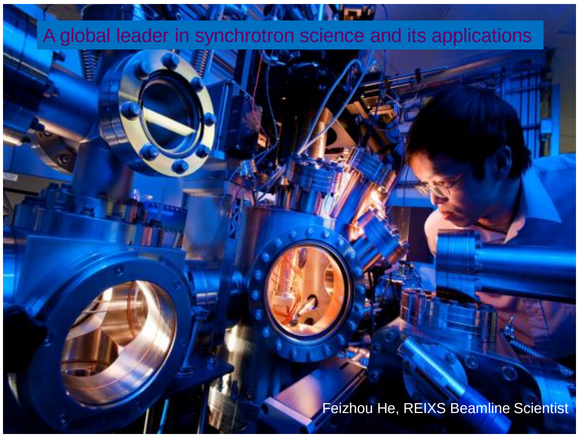
Quality of scientific research in the context of the field
Does the proposal describe what is to be studied and the importance of it? What hypothesis would be tested, how will the results impact the field, and what is the likelihood of success?

Suitability of CLS resources being allocated relative to the proposed research
Is this a good use of CLS resources? Does the experiment require the resources being requested? Reviewers are also asked to comment on the appropriateness of the number of shifts that have been requested.

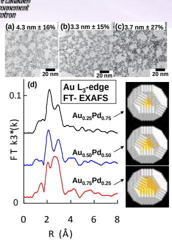
Quality and capability of the researchers based on their track record
Does the research team have recent synchrotron and/or other relevant experience? If they are a past user they should have clearly demonstrated their track record and productivity in the proposal.

Peer Review Access

	2009	2010	2011
Number of shifts requested	1768	2675	3456
Number of shifts allocated	1252	1816	2203
Oversubscription	41%	47%	57%

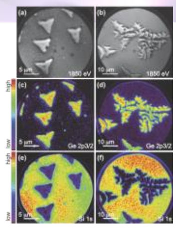


Nanoscience



The local structure of Au-Pd nanoparticles capped with mixed amine and bromide ligands: An EXAFS Study

F. Liu and P. Zhang
Department of Chemistry, Dalhousie University



Si/Ge Intermixing in Very Large Ge Islands on Si(111)

J. M. MacLeod (1, 2), J. A. Lipton-Duffin (1, 2),
F. Rosei (1)
(1) INRS-EMT, Université du Québec, 1650 Boul. Lionel Boulet J3X 1S2 Varennes (QC), Canada
(2) Current address: Dipartimento di Fisica, Università degli Studi di Trieste, Trieste (TS), Italy

Nanoscale Chemical Imaging of the Reduction Behaviour of a Single Catalyst Particle

E. de Smit (1), I. Swart (1), J. F. Creemer (2), C. Karunakaran (3), D. Bertwistle (3), H. W. Zandbergen (2), B.M. Weckhuysen (1) and F. M. F. de Groot (1)
(1) Utrecht University, The Netherlands
(2) Delft University of Technology, The Netherlands
(3) Canadian Light Source, Inc.

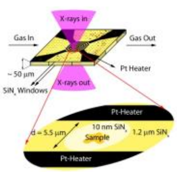


Figure 1: Description and relevant dimensions of the nanoreactor chamber.

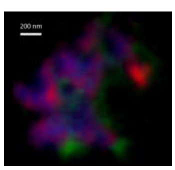
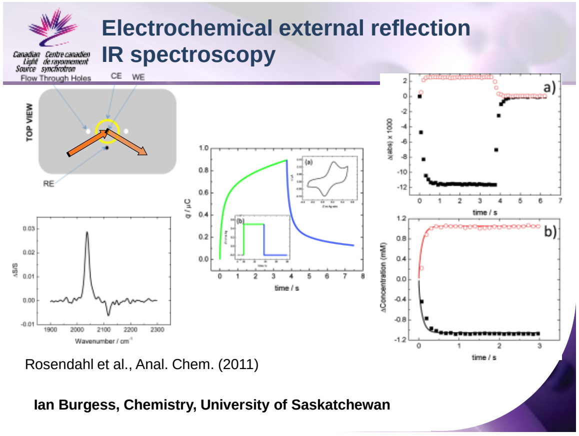
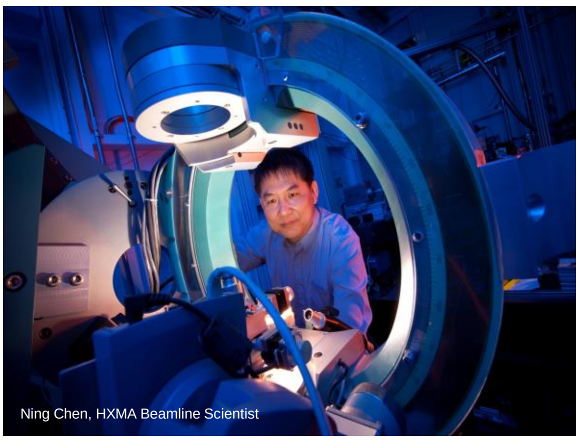
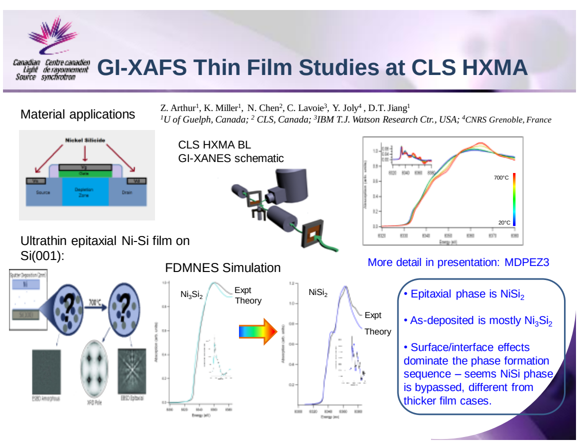


Figure 2: Chemical species contour map showing the distribution of Fe-species of different valence after treatment at 250°C in H_2. Blue: mixed $Fe^{2+/3+}$ (Fe_3O_4), green: pure Fe^{2+}, red: Fe^0.

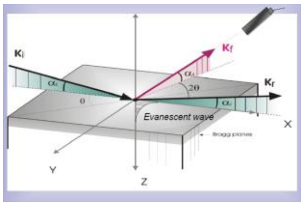

Electrochemical external reflection IR spectroscopy
Canadian Light Source
Centre canadien de rayonnement synchrotron
Flow Through Holes
CE
WE
TOP VIEW
RE
a)
b)
time / s
q / μC
ΔConcentration (mM)
Wavenumber / cm⁻¹
Rosendahl et al., Anal. Chem. (2011)
Ian Burgess, Chemistry, University of Saskatchewan

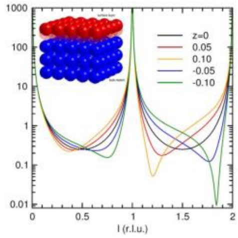

Ning Chen, HXMA Beamline Scientist


GI-XAFS Thin Film Studies at CLS HXMA
Canadian Light Source
Centre canadien de rayonnement synchrotron
Material applications
Z. Arthur¹, K. Miller¹, N. Chen², C. Lavoie³, Y. Joly⁴, D.T. Jiang¹
¹U of Guelph, Canada; ² CLS, Canada; ³IBM T.J. Watson Research Ctr., USA; ⁴CNRS Grenoble, France
Nickel Silicide
CLS HXMA BL
GI-XANES schematic
700°C
20°C
Ultrathin epitaxial Ni-Si film on Si(001):
FDMNES Simulation
Ni3Si2
Expt
Theory
NiSi2
Expt
Theory
More detail in presentation: MDPEZ3
• Epitaxial phase is NiSi2
• As-deposited is mostly Ni3Si2
• Surface/interface effects dominate the phase formation sequence – seems NiSi phase is bypassed, different from thicker film cases.

Surface X-ray Scattering

X-ray scattering from an infinite crystal → Bragg peaks.
Presence of crystalline surfaces → truncation rods (normal to the surface).
Crystal Truncation Rod (CTR) measurements allow detailed determination of atomic structure at the surface.



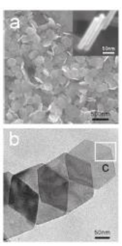


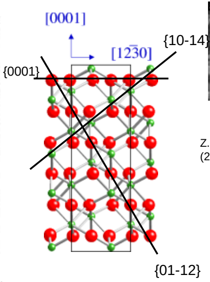
P. Willmott, Zuoz Summer School, 2008

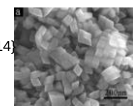
Applying Surface X-ray diffraction technique

to uniform shape, mono-dispersive single crystalline nanoparticle →
Correlation of enhanced performance of nanoparticle to its surface structure

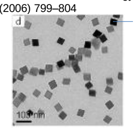
Shape control of α-Fe_2O_3 nanoparticles







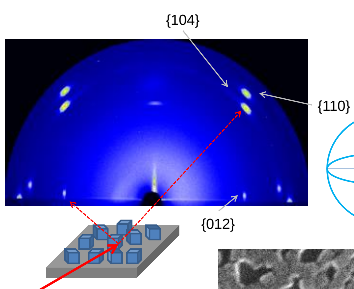
α-Fe_2O_3 nanorhombohedra
Z. Pu et al, Nanotechnology 17 (2006) 799–804

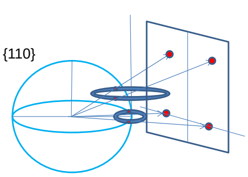


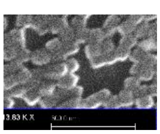
α-Fe_2O_3 nanoplate,
L. Chen et al, Inorg. Chem. 2010, 49, 8411–8420

α-Fe_2O_3 nanocube
Y. Zheng et al, J. Phys. Chem. B 2006, 110, 3093

Grazing incidence X-ray diffraction (GIXRD)
from dip-coated hematite (α-Fe_2O_3) nano-cubes

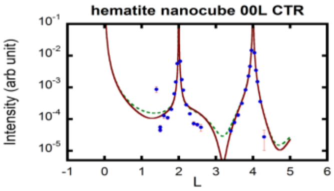


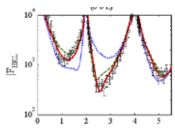




SEM image (CLS SyLMAND)

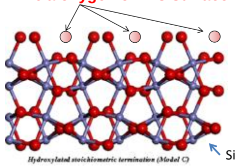
Crystal truncation rod (CTR) from **α-Fe_2O_3(012) nanocube**





CTR from single crystal
K.S. Tanwar et al. / Surface Science 601 (2007) L59–L64

Extra oxygen on NC surface



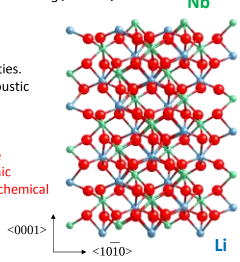
Single crystal model

Existence of extra oxygen on hydroxylated nanocube surface agrees well with observations that nanoparticle can be easily hydroxylated

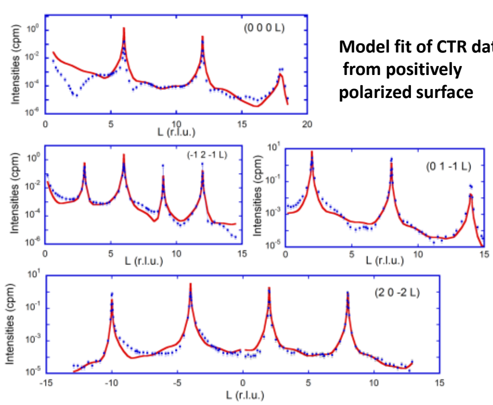
Surface X-ray Scattering Study of Polarization Dependent Surface Structure and Stoichiometry of $LiNbO_3$(0001)

Lithium Niobate (LiNbO3)
•Ferroelectric material with pyroelectric, piezoelectric and nonlinear optical properties.
•Widely used for electro-optic, surface acoustic wave generation, and second harmonic generation.

Oppositely poled LNO(0001) surfaces have different stoichiometries , atomic/electronic structures, photo-catalytic activities , and chemical reactions.

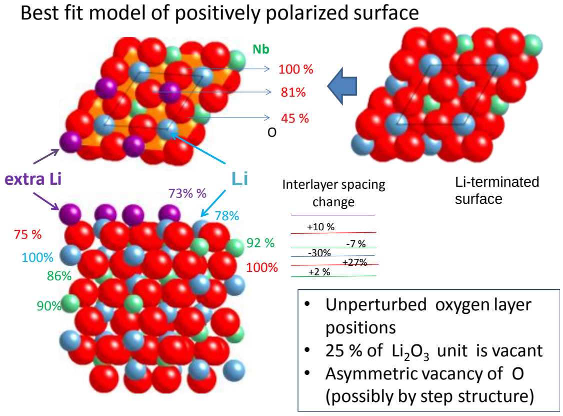


Surface structure characterization is essential for further study of the polarization dependent properties.



Model fit of CTR data from positively polarized surface

Best fit model of positively polarized surface



- Unperturbed oxygen layer positions
- 25 % of Li_2O_3 unit is vacant
- Asymmetric vacancy of O (possibly by step structure)

RSXS Endstation

- Resonant Soft X-ray Scattering (RSXS)
- X-ray Absorption Spectroscopy (XAS) by TEY and TFY
- Magnetic Circular Dichroism (MCD)
- X-ray Reflectivity

Feizhou He

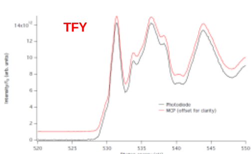
Experimental Techniques

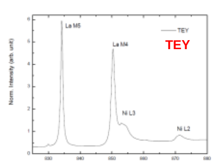
- X-ray Absorption Spectroscopy
  - TEY – sample current
  - TFY – Photodiode, Channeltron, Microchannel Plate (MCP)
- XMCD – X-ray Magnetic Circular Dichroism

  High energy resolution

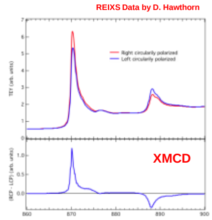
  Polarized incoming beam

  Measure TEY, specular reflection, fluorescence yield simultaneously





REIXS Data by D. Hawthorn



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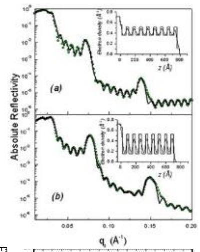
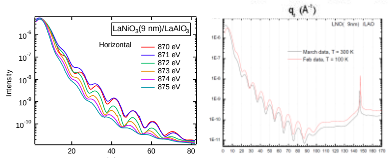
Experimental Techniques

- X-ray Reflectivity
  - Wide 2θ and θ range (maximum 2θ: 172°)
  - Energy dependence, temperature dependence, polarization dependence

Information on:
- Electron density profile in thin films, multilayers, interface
- Film thickness, multilayer periodicity
- Roughness of surface and interface





REIXS Data by H. Wadati

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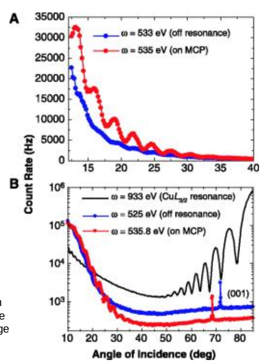
Resonant Soft X-Ray Scattering

At resonance we have contrast for:
- Elements – each element has specific resonant energy → element selective
- Valence electron density
- Bond orientation; orbital ordering quadrupole moment orientation [linear pol. light]
- Spin density [circular pol. light and *p* or *d* core level]

P. Abbamonte et al, Science 297, 581 (2002).



$La_2CuO_{4+\delta}$ film
O *K* edge
Cu *L* edge

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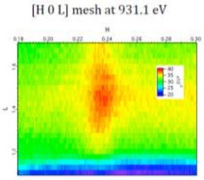
Resonant Soft X-Ray Scattering

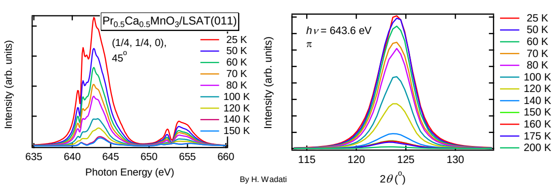
- REIXS RSXS
  - Temperature 18K – 400K
  - Energy 100 eV – 2500 eV
  - Arbitrary Polarization

  - FixQ energy scan
  - Reciprocal space mapping

[H 0 L] mesh at 931.1 eV



By D. Hawthorn



By H. Wadati

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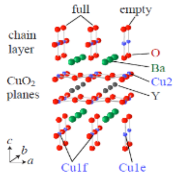
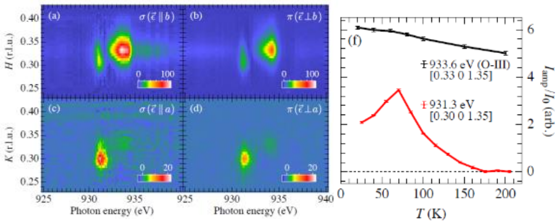
Research at REIXS

Charge ordering in chain layer and plane layer in YBCO



A. Achkar et al, PRL (2012)



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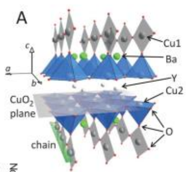
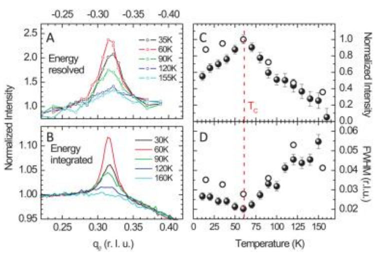
Research at REIXS

Charge density wave in YBCO



G. Ghiringhelli et al, Science (2012).



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CLS Science Highlights

Download or request a copy:
http://www.lightsource.ca/science/activity_reports.php

Research Report 2011

- Imaging Electronic Ripples and Doped Regions in Graphene
- Voltage Control of Surface Magnetization Domains in a Magnetoelectric Antiferromagnet
- X-ray Scattering Study of the Structural Phase Transition in $La_{1.8}Sr_{0.2}Fe_{0.01}O_4$
- Temperature-dependent and in-situ Electrochemical XAFS Studies of RuO_2/Carbon Nanocomposites
- Nano-scale Chemical Imaging of a Single Sheet of Reduced Graphene Oxide
- Non-statistical Dopant Distributions of Ln^{3+}-doped $NaGdF_4$ Nanoparticles
- Time-resolved FTIR Microscopy Studies of Electrochemical Reactions